

FMOS054N03

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FMOS054N03

5.4A 30V N-Channel Enhancement Mode Power MOSFET

Features

- $V_{DS}=30V$, $I_D=5.4A$.
- $R_{DS(ON)} \leq 24m\Omega$ @ $V_{GS}=10V$, $I_D=5.8A$.
- $R_{DS(ON)} \leq 31m\Omega$ @ $V_{GS}=4.5V$, $I_D=5.0A$.
- Simple drive requirement.
- Reliable and rugged.
- Lead-free parts meet RoHS requirements.
- Suffix "-H" indicates halogen-free part, ex: FMOS054N03-H.

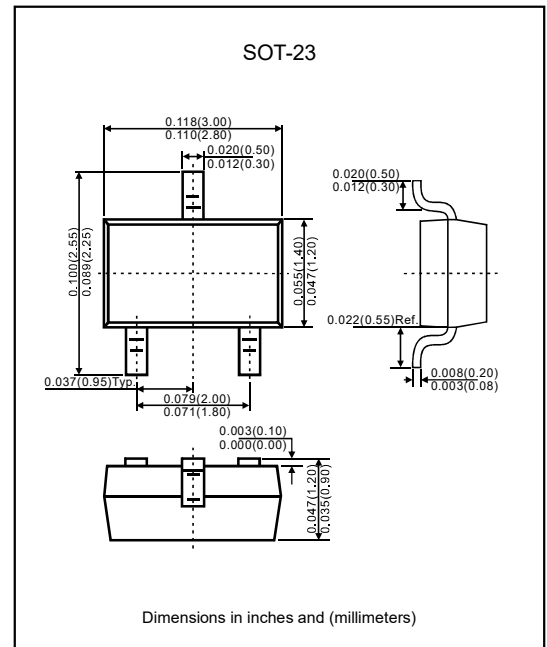
Applications

- Portable equipment.
- Battery powered system.

Mechanical data

- Epoxy: UL94-V0 rated flame retardant.
- Case : Molded plastic, SOT-23.
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.
- Mounting Position : Any.

Package outline



Maximum ratings ($T_J=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Ratings	Unit	
Drain-source voltage	V_{DS}	30	V	
Gate-source voltage	V_{GS}	± 20	V	
Continuous drain current	I_D	($T_A=25^\circ C$)	5.4	A
		($T_A=70^\circ C$)	4.3	
Pulse drain current tested (Note1)	I_{DM}	11.2	A	
Avalanche current, single pulse (Note2)	I_{AS}	11	A	
Avalanche energy, single pulse (Note2)	E_{AS}	6	mJ	
Power dissipation	P_D	($T_A=25^\circ C$)	1.1	W
		($T_A=70^\circ C$)	0.7	
Thermal resistance, junction to ambient (Note3) (steady state)	$R_{\theta JA}$	110	$^\circ C/W$	
Operating Junction temperature	T_J	+150	$^\circ C$	
Storage temperature range	T_{STG}	-55 to +150	$^\circ C$	

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Electrical characteristics (At $T_j=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	30			V
Drain-source leakage current	I_{DSS}	$V_{DS}=24\text{V}$, $V_{GS}=0\text{V}$			1	μA
Gate-source leakage current	I_{GSS}	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$			± 100	nA
On characteristics						
Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	1	1.5	2	V
Forward transconductance	g_{FS}	$V_{DS}=3\text{V}$, $I_D=3\text{A}$		8.6		S
Static drain-source on-resistance (Note4)	$R_{DS(ON)}$	$V_{GS}=10\text{V}$, $I_D=5.8\text{A}$		20	24	m Ω
		$V_{GS}=4.5\text{V}$, $I_D=5\text{A}$		24	31	
Dynamic Parameters (Note5)						
Gate resistance	R_G	$V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1.0\text{MHz}$		3.3		Ω
Input capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=15\text{V}$, $f=1.0\text{MHz}$		500		pF
Output capacitance	C_{oss}			62		
Reverse transfer capacitance	C_{rss}			53		
Switching parameters						
Total gate charge	Q_g	$V_{GS}=4.5\text{V}$, $V_{DS}=15\text{V}$, $I_D=10\text{A}$		8.4		nC
		$V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $I_D=10\text{A}$		15		
Gate to source charge	Q_{gs}			1.2		
Gate to Drain charge	Q_{gd}		4.6			
Turn-on delay time	$t_{d(on)}$	$V_{DS}=15\text{V}$, $V_{GS}=10\text{V}$, $I_D=1\text{A}$, $R_G=6\Omega$		3.1		ns
Rise time	t_r			21		
Turn-off delay time	$t_{d(off)}$			25		
Fall time	t_f			18		
Source-drain diode ratings and characteristics						
Drain - source diode forward voltage (Note4)	V_{SD}	$I_{SD}=1\text{A}$, $V_{GS}=0\text{V}$		0.8	1.1	V
Reverse recovery time	t_{rr}	$I_F=1\text{A}$, $V_R=15\text{V}$, $dI_F/dt=100\text{A}/\mu\text{s}$		1.3		ns
Reverse recovery charge	Q_{rr}			4.9		nC

Note: 1. Max. current is limited by bonding wire.

2. UIS tested and pulse width are limited by maximum junction temperature 150°C .

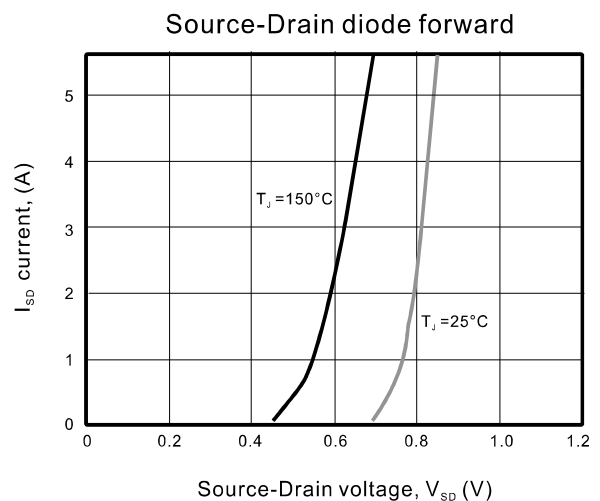
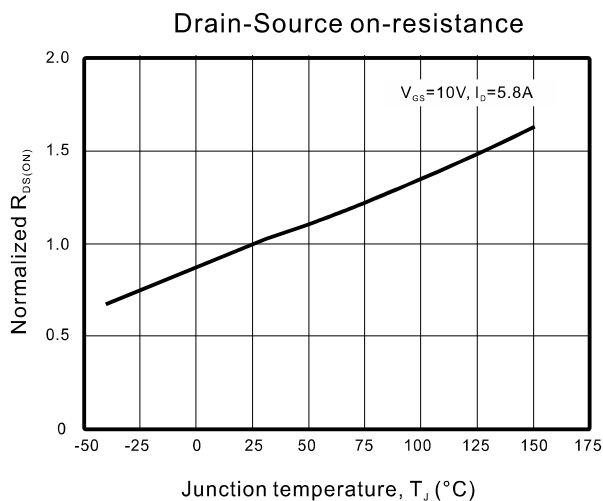
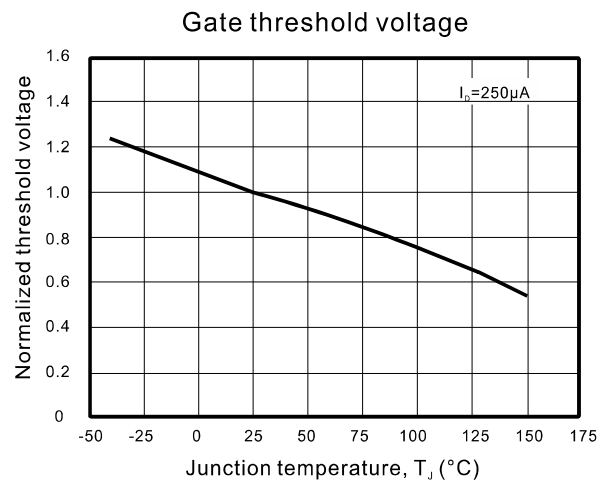
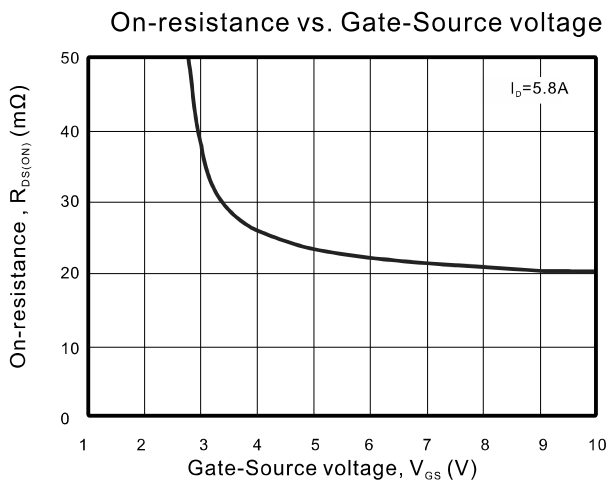
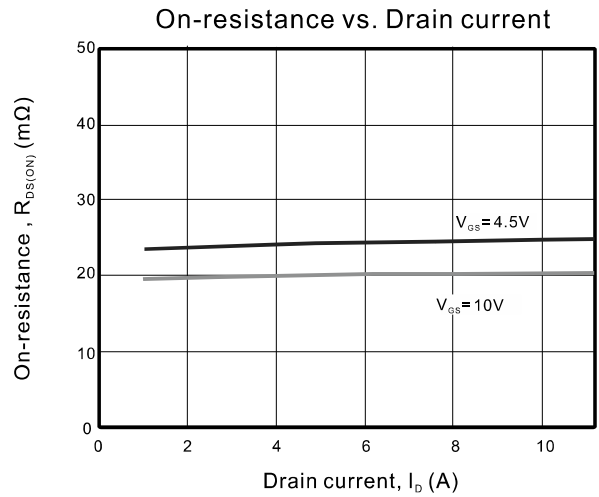
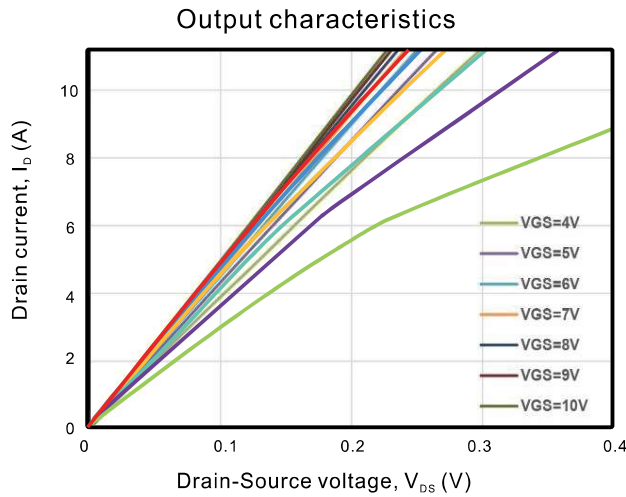
3. Surface mounted on 1in^2 FR-4 board with 1oz.

4. Pulse test (pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).

5. Guaranteed by design, not subject to production testing.

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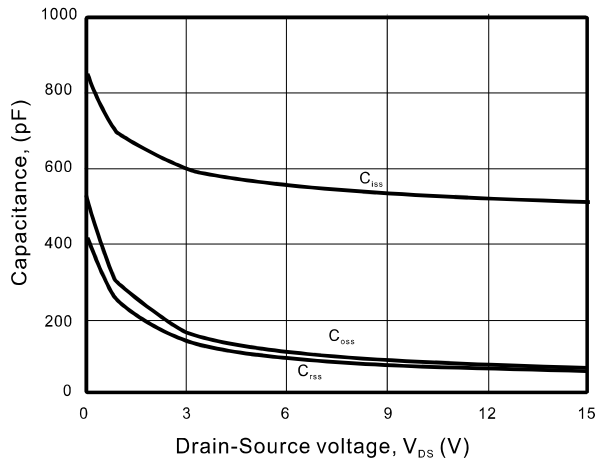
Rating and characteristic curves



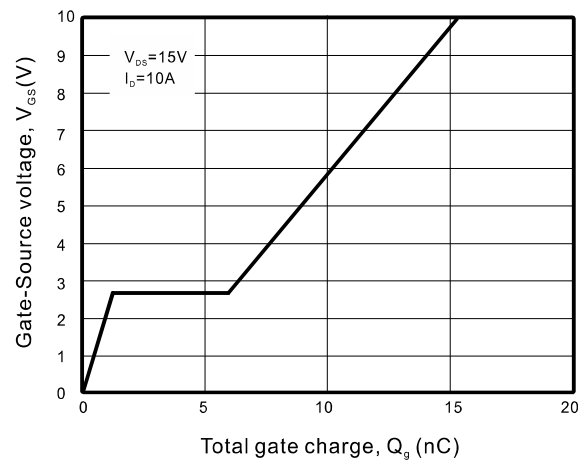
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Rating and characteristic curves

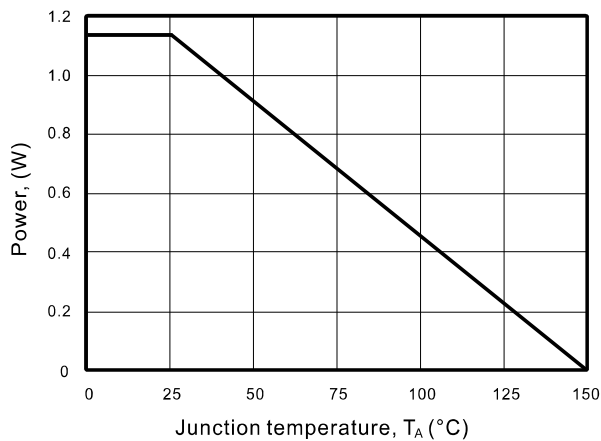
Capacitance



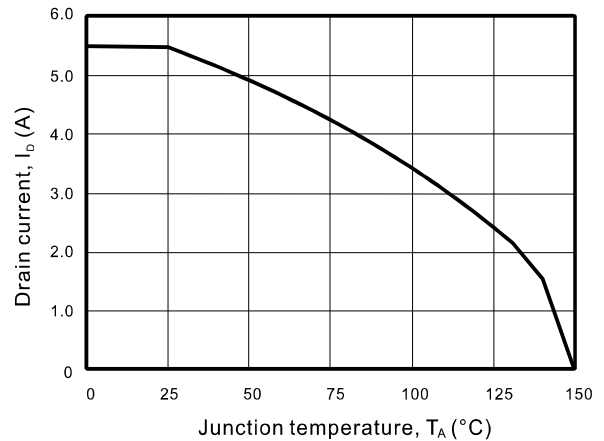
Gate charge characteristics



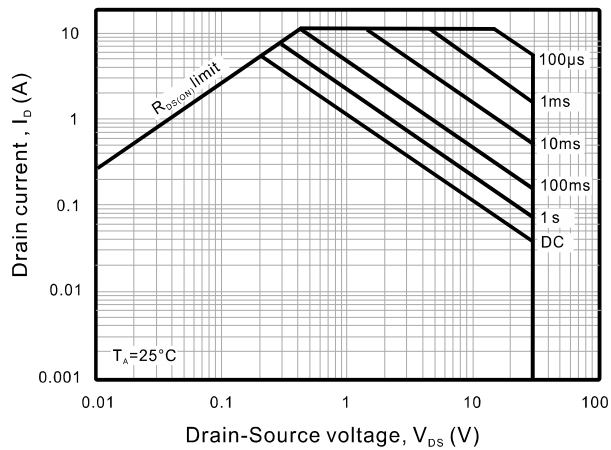
Power dissipation



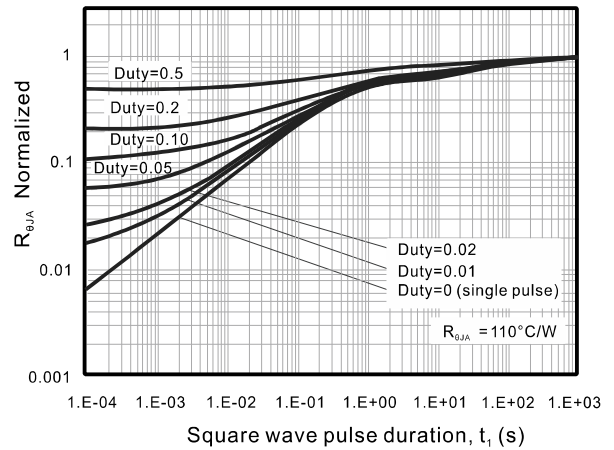
Drain current



Safe operating area

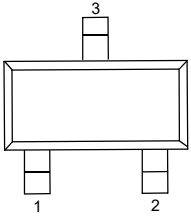
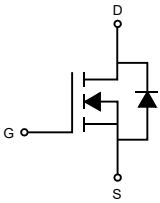


$R_{\theta JA}$ transient thermal impedance



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Pinning information

Pin	Simplified outline	Symbol
Pin1 Gate Pin2 Source Pin3 Drain		

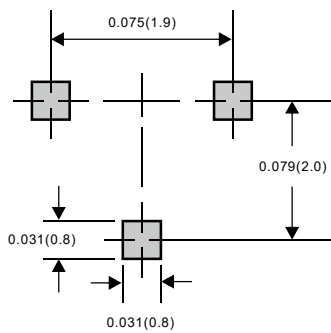
Marking

Type number	Marking code
FMOS054N03	15YWS

*15 : Product code.
 YWS: Wafer lot code.
 Y: Year
 W: Weekly
 S: Sequence

Suggested solder pad layout

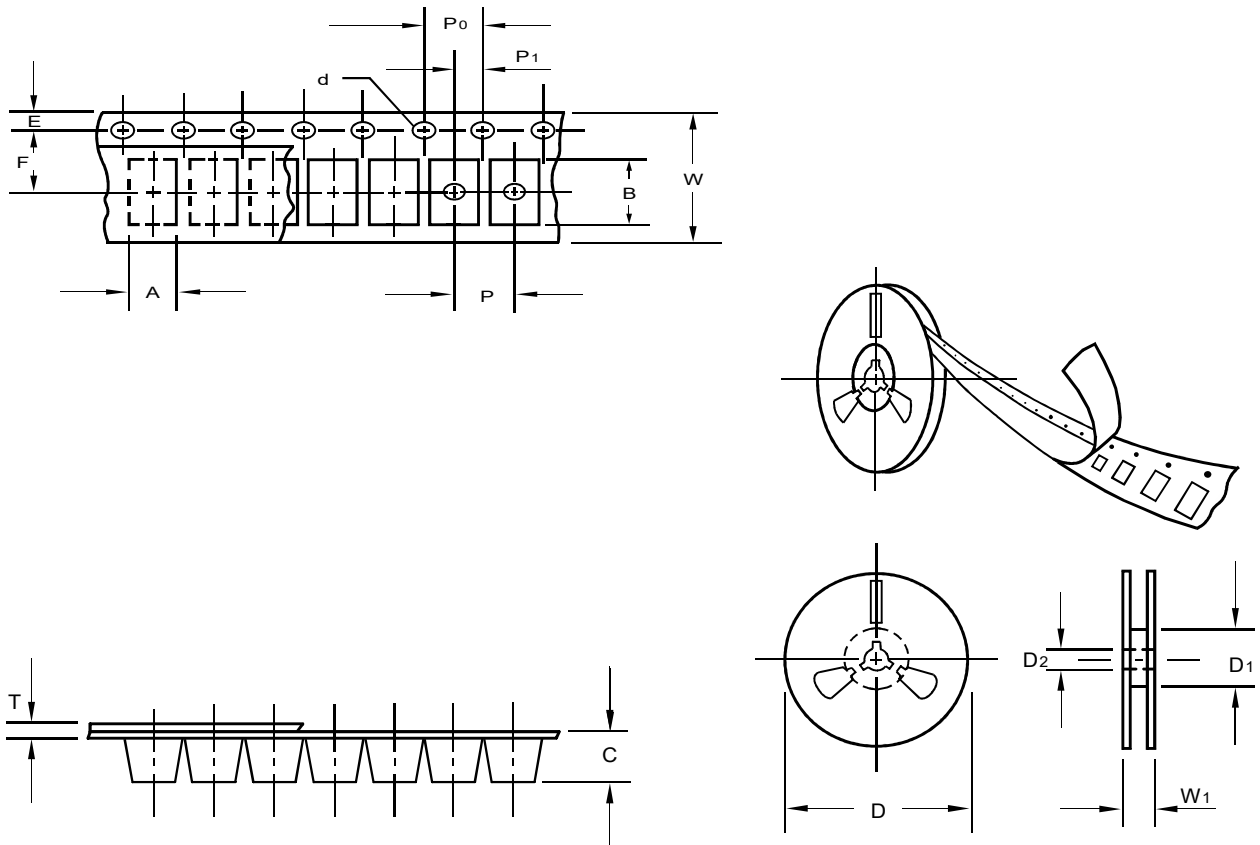
SOT-23



Dimensions in inches and (millimeters)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

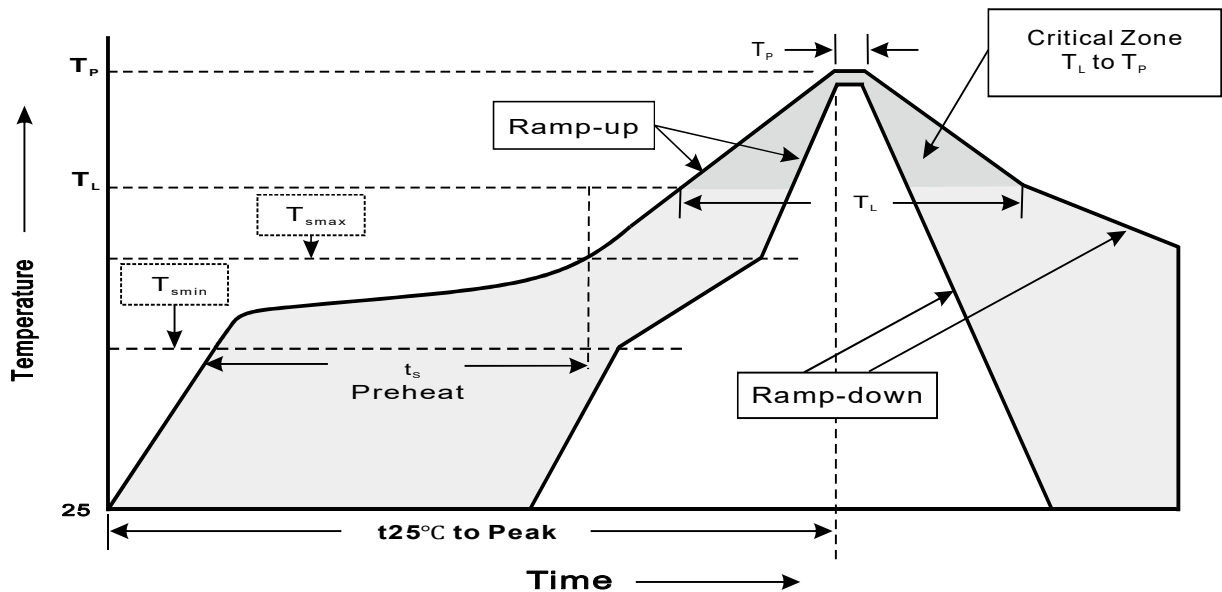
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Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000

Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



3.Reflow soldering

Profile feature	Soldering Condition
Average ramp-up rate (T_L to T_p)	< 3°C/sec
Preheat -Temperature Min (T_{smin}) -Temperature Max (T_{smax}) -Time (min to max) (t_s)	150°C 200°C 60 ~ 120sec
T_{smax} to T_L -Ramp-up rate	< 3°C/sec
Time maintained above: -Temperature (T_L) -Time(T_L)	217°C 60 ~ 260 sec
Peak Temperature(T_p)	255°C -0/+5°C
Time within 5°C of actual peak Temperature(T_p)	10 ~ 30sec
Ramp-down rate	< 6°C/sec
Time 25°C to peak temperature	< 6 minutes